


<b>Search Notes</b>  	<b>Application/Control No.</b>  10825242	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL.
	<b>Examiner</b>  YUK CHOW	<b>Art Unit</b>  2629

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	76, 204,212	12/22/2008	YC

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST	12/22/2008	YC
sample holder could be transistors that hold data as in Kasai Fig. 6(42))	7/16/2009	YC

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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